

Search Notes

Application/Control No.

10/685,322

Examiner

Ren L. Yan

Applicant(s)/Patent under
Reexamination

HIRST ET AL.

Art Unit

2854

SEARCHED

Class	Subclass	Date	Examiner
search updated		3/20/06	RY

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR